TEXAS ОРА333A-EP, ОРА2333A-EP INSTRUMENTS

## 1.8-V MICROPOWER CMOS OPERATIONAL AMPLIFIERS ZERO-DRIFT SERIES

## FEATURES

- Low Offset Voltage: $23 \mu \mathrm{~V}$ (Max)
- 0.01-Hz to $10-\mathrm{Hz}$ Noise: $1.1 \mu \mathrm{~V}_{\mathrm{PP}}$
- Quiescent Current: $17 \mu \mathrm{~A}$
- Single-Supply Operation
- Supply Voltage: 1.8 V to 5.5 V
- Rail-to-Rail Input/Output
- MicroSize Packages: SC70 and SOT23


## APPLICATIONS

- Transducer Applications
- Temperature Measurements
- Electronic Scales
- Medical Instrumentation
- Battery-Powered Instruments
- Handheld Test Equipment


## SUPPORTS DEFENSE, AEROSPACE, AND MEDICAL APPLICATIONS

- Controlled Baseline
- One Assembly/Test Site
- One Fabrication Site
- Available in Military ( $-55^{\circ} \mathrm{C} / 125^{\circ} \mathrm{C}$ )

Temperature Range ${ }^{(1)}$

- Extended Product Life Cycle
- Extended Product-Change Notification
- Product Traceability




## DESCRIPTION/ORDERING INFORMATION

The OPA333A series of CMOS operational amplifiers uses a proprietary auto-calibration technique to simultaneously provide very low offset voltage ( $10 \mu \mathrm{~V}$ max) and near-zero drift over time and temperature. These miniature, high-precision, low-quiescent-current amplifiers offer high-impedance inputs that have a common-mode range 100 mV beyond the rails, and rail-to-rail output that swings within 50 mV of the rails. Single or dual supplies as low as $1.8 \mathrm{~V}( \pm 0.9 \mathrm{~V})$ and up to $5.5 \mathrm{~V}( \pm 2.75 \mathrm{~V})$ may be used. They are optimized for low-voltage single-supply operation.
The OPA333A family offers excellent common-mode rejection ratio (CMRR) without the crossover associated with traditional complementary input stages. This design results in superior performance for driving analog-to-digital converters (ADCs) without degradation of differential linearity.
The OPA333A (single version) is available in the SC70-5 and SOT23-5 packages. The OPA2333A (dual version) is offered in the SO-8 package. All versions are specified for operation from $-55^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$.

ORDERING INFORMATION ${ }^{(1)}$

| PRODUCT | PACKAGE-LEAD | PACKAGE DESIGNATOR | PACKAGE MARKING ${ }^{(2)}$ |
| :---: | :---: | :---: | :---: |
| OPA333AMDBVREP | SOT23-5 | DBV | OBYM |
| OPA333AMDCKREP | SC70-5 | DCK | CHQ |
| OPA2333AMDREP | SO-8 | D | $2333 E P$ |

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI Web site at www.ti.com.
(2) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.


PIN CONFIGURATIONS


## Absolute Maximum Ratings ${ }^{(1)}$

over operating free-air temperature range (unless otherwise noted)

|  |  | MIN | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: |
| Supply voltage |  |  | 7 | V |
| Signal input terminals, voltage ${ }^{(2)}$ |  | -0.3 | $(\mathrm{V}+)+0.3$ | V |
| Output short circuit ${ }^{(3)}$ |  |  | Continuous |  |
| Operating temperature range |  | -55 | 125 | ${ }^{\circ} \mathrm{C}$ |
| Storage temperature range |  | -65 | $150{ }^{(4)}$ | ${ }^{\circ} \mathrm{C}$ |
| Junction temperature |  |  | 150 | ${ }^{\circ} \mathrm{C}$ |
| ESD rating | Human-Body Model (HBM) |  | 4000 | V |
|  | Charged-Device Model (CDM) |  | 1000 |  |

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) Input terminals are diode clamped to the power-supply rails. Input signals that can swing more than 0.3 V beyond the supply rails should be current limited to 10 mA or less.
(3) Short circuit to ground, one amplifier per package
(4) Long-term high-temperature storage and/or extended use at maximum recommended operating conditions may result in a reduction of overall device life. See http://www.ti.com/ep_quality for additional information on enhanced plastic packaging.
www.ti.com

## Electrical Characteristics: $\mathrm{V}_{\mathrm{S}}=1.8 \mathrm{~V}$ to 5.5 V

Boldface limits apply over the specified temperature range, $T_{A}=-55^{\circ} \mathbf{C}$ to $\mathbf{1 2 5}{ }^{\circ} \mathrm{C}$. At $T_{A}=25^{\circ} \mathrm{C}, \mathrm{R}_{\mathrm{L}}=10 \mathrm{k} \Omega$ connected to $\mathrm{V}_{\mathrm{S}} / 2, \mathrm{~V}_{\mathrm{CM}}=\mathrm{V}_{\mathrm{S}} / 2$, and $\mathrm{V}_{\text {OUT }}=\mathrm{V}_{\mathrm{S}} / 2$ (unless otherwise noted).

| PARAMETER |  | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| OFFSET VOLTAGE <br> Input offset voltage <br> over temperature <br> vs temperature <br> vs power supply <br> Long-term stability ${ }^{(1)}$ <br> Channel separation, dc | $\mathrm{V}_{\mathrm{OS}}$ <br> $\mathrm{dV}_{\mathrm{OS}} / \mathrm{d}_{\mathrm{T}}$ PSRR | $V_{S}=5 \mathrm{~V}$ $V_{S}=1.8 \mathrm{~V} \text { to } 5.5 \mathrm{~V}$ |  | $\begin{array}{r} 2 \\ \\ 0.02 \\ 1 \\ (1) \\ 0.1 \\ \hline \end{array}$ | $\begin{aligned} & 10 \\ & 22 \end{aligned}$ <br> 6 | $\begin{gathered} \mu \mathrm{V} \\ \mu \mathrm{~V} \\ \mu \mathrm{~V} /{ }^{\circ} \mathrm{C} \\ \mu \mathrm{~V} / \mathrm{V} \end{gathered}$ |
| INPUT BIAS CURRENT <br> Input bias current over Temperature Input offset current | $I_{B}$ <br> los |  |  | $\begin{array}{r}  \pm 70 \\ \pm 150 \\ \pm 140 \end{array}$ | $\pm 200$ $\pm 400$ | pA <br> pA <br> pA |
| NOISE <br> Input voltage noise, $\mathrm{f}=0.01 \mathrm{~Hz}$ to 1 Hz Input voltage noise, $\mathrm{f}=0.1 \mathrm{~Hz}$ to 10 Hz Input current noise, $\mathrm{f}=10 \mathrm{~Hz}$ | $i_{n}$ |  |  | 0.3 1.1 100 |  | $\begin{gathered} \mu \mathrm{V}_{\mathrm{PP}} \\ \mu \mathrm{~V}_{\mathrm{PP}} \\ \mathrm{fA} / \sqrt{\mathrm{Hz}} \end{gathered}$ |
| INPUT VOLTAGE RANGE <br> Common mode voltage range Common-Mode Rejection Ratio | $V_{C M}$ <br> CMRR | $(\mathrm{V}-)-0.1 \mathrm{~V}<\mathrm{V}_{\mathrm{CM}}<\left(\mathrm{V}_{+}\right)+0.1 \mathrm{~V}$ | $\begin{array}{r} (V-)-0.1 \\ 102 \end{array}$ | 130 | $(\mathrm{V}+)+0.1$ | V dB |
| INPUT CAPACITANCE <br> Differential <br> Common mode |  |  |  | 2 4 |  | $\begin{aligned} & \mathrm{pF} \\ & \mathrm{pF} \end{aligned}$ |
| OPEN-LOOP GAIN Open-loop voltage gain | $\boldsymbol{A}_{O L}$ | $\begin{gathered} (\mathrm{V}-)+100 \mathrm{mV}<\mathrm{V}_{\mathrm{O}}<\left(\mathrm{V}_{+}\right)-100 \mathrm{mV}, \\ \mathrm{R}_{\mathrm{L}}=10 \mathrm{k} \Omega \end{gathered}$ | 104 | 130 |  | dB |
| FREQUENCY RESPONSE <br> Gain-bandwidth product Slew rate | GBW <br> SR | $\begin{gathered} C_{L}=100 \mathrm{pF} \\ \mathrm{G}=1 \end{gathered}$ |  | $\begin{gathered} 350 \\ 0.16 \end{gathered}$ |  | kHz <br> V/us |
| OUTPUT <br> Voltage output swing from rail over temperature <br> Short-circuit current <br> Capacitive load drive <br> ${ }^{(2)}$ Open-loop output impedance | $\begin{gathered} \text { ISC } \\ \text { CL } \end{gathered}$ | $\begin{gathered} R_{\mathrm{L}}=10 \mathrm{k} \Omega \\ \mathbf{R}_{\mathrm{L}}=10 \mathrm{k} \Omega \\ \mathrm{f}=350 \mathrm{kHz}, \mathrm{l}_{\mathrm{O}}=0 \end{gathered}$ |  | 30 $\pm 5$ 2 | $\begin{aligned} & 50 \\ & 85 \end{aligned}$ | mV <br> mV <br> mA <br> $\mathrm{k} \Omega$ |
| POWER SUPPLY <br> Specified voltage range Quiescent current per amplifier <br> over temperature <br> Turn-on time | $\begin{aligned} & \mathrm{v}_{\mathrm{S}} \\ & \mathrm{I}_{\mathrm{Q}} \end{aligned}$ | $\begin{gathered} \mathrm{l}_{\mathrm{O}}=0 \\ \mathrm{v}_{\mathrm{S}}=5 \mathrm{~V} \end{gathered}$ | 1.8 | 17 100 | $\begin{aligned} & 5.5 \\ & 25 \\ & 30 \end{aligned}$ | V $\mu \mathrm{A}$ $\mu \mathrm{A}$ $\mu \mathrm{s}$ |
| TEMPERATURE RANGE <br> Specified range |  |  | -55 |  | 125 | ${ }^{\circ} \mathrm{C}$ |

(1) 300 -hour life test at $150^{\circ} \mathrm{C}$ demonstrated randomly distributed variation of approximately $1 \mu \mathrm{~V}$
(2) See Typical Characteristics

Electrical Characteristics: $\mathrm{V}_{\mathrm{S}}=1.8 \mathrm{~V}$ to 5.5 V (continued)
Boldface limits apply over the specified temperature range, $T_{A}=-55^{\circ} \mathbf{C}$ to $\mathbf{1 2 5}{ }^{\circ} \mathrm{C}$. At $T_{A}=25^{\circ} \mathrm{C}, R_{L}=10 \mathrm{k} \Omega$ connected to $\mathrm{V}_{\mathrm{S}} / 2, \mathrm{~V}_{\mathrm{CM}}=\mathrm{V}_{\mathrm{S}} / 2$, and $\mathrm{V}_{\text {OUT }}=\mathrm{V}_{\mathrm{S}} / 2$ (unless otherwise noted).

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX |
| :--- | :---: | :---: | :---: | :---: |
|  |  | UNIT |  |  |
| Operating range |  | -55 |  | 125 |
| Storage range |  | -65 |  | 150 |
| Thermal resistance |  | ${ }^{\circ} \mathrm{C}$ |  |  |
| SOT23-5 |  |  |  |  |
| SO-8 |  | 200 |  |  |
| SC70-5 |  |  | 150 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |

TYPICAL CHARACTERISTICS
At $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{S}}=5 \mathrm{~V}$, and $\mathrm{C}_{\mathrm{L}}=0 \mathrm{pF}$ (unless otherwise noted).



Offset Voltage ( $\mu \mathrm{V}$ )



TYPICAL CHARACTERISTICS (continued)







TYPICAL CHARACTERISTICS (continued)


## TYPICAL CHARACTERISTICS (continued)

CURRENT AND VOLTAGE NOISE SPECTRAL DENSITY vs FREQUENCY


## APPLICATION INFORMATION

The OPA333A and OPA2333A are unity-gain stable and free from unexpected output phase reversal. They use a proprietary auto-calibration technique to provide low offset voltage and very low drift over time and temperature. For lowest offset voltage and precision performance, circuit layout and mechanical conditions should be optimized. Avoid temperature gradients that create thermoelectric (Seebeck) effects in the thermocouple junctions formed from connecting dissimilar conductors. These thermally-generated potentials can be made to cancel by ensuring they are equal on both input terminals. Other layout and design considerations include:

- Use low thermoelectric-coefficient conditions (avoid dissimilar metals)
- Thermally isolate components from power supplies or other heat sources
- Shield op amp and input circuitry from air currents, such as cooling fans

Following these guidelines will reduce the likelihood of junctions being at different temperatures, which can cause thermoelectric voltages of $0.1 \mu \mathrm{~V} /{ }^{\circ} \mathrm{C}$ or higher, depending on materials used.

## Operating Voltage

The OPA333A and OPA2333A op amps operate over a power-supply range of 1.8 V to 5.5 V ( $\pm 0.9 \mathrm{~V}$ to $\pm 2.75 \mathrm{~V}$ ). Supply voltages higher than 7 V (absolute maximum) can permanently damage the device. Parameters that vary over supply voltage or temperature are shown in the Typical Characteristics section of this data sheet.

## Input Voltage

The OPA333A and OPA2333A input common-mode voltage range extends 0.1 V beyond the supply rails. The OPA333A is designed to cover the full range without the troublesome transition region found in some other rail-to-rail amplifiers.

Normally, input bias current is about 70 pA ; however, input voltages exceeding the power supplies can cause excessive current to flow into or out of the input pins. Momentary voltages greater than the power supply can be tolerated if the input current is limited to 10 mA . This limitation is easily accomplished with an input resistor(see Figure 1).


Figure 1. Input Current Protection

## Internal Offset Correction

The OPA333A and OPA2333A op amps use an auto-calibration technique with a time-continuous $350-\mathrm{kHz}$ op amp in the signal path. This amplifier is zero corrected every $8 \mu \mathrm{~s}$ using a proprietary technique. Upon power up, the amplifier requires approximately $100 \mu$ s to achieve specified $\mathrm{V}_{\text {OS }}$ accuracy. This design has no aliasing or flicker noise.

## Achieving Output Swing to the Op Amp Negative Rail

Some applications require output voltage swings from 0 V to a positive full-scale voltage (such as 2.5 V ) with excellent accuracy. With most single-supply op amps, problems arise when the output signal approaches 0 V , near the lower output swing limit of a single-supply op amp. A good single-supply op amp may swing close to single-supply ground, but will not reach ground. The output of the OPA333A and OPA2333A can be made to swing to ground, or slightly below, on a single-supply power source. To do so requires the use of another resistor and an additional, more negative, power supply than the op amp negative supply. A pulldown resistor may be connected between the output and the additional negative supply to pull the output down below the value that the output would otherwise achieve (see Figure 2).


Figure 2. $\mathrm{V}_{\text {OUT }}$ Range to Ground
The OPA333A and OPA2333A have an output stage that allows the output voltage to be pulled to its negative supply rail, or slightly below, using the technique previously described. This technique only works with some types of output stages. The OPA333A and OPA2333A have been characterized to perform with this technique; however, the recommended resistor value is approximately $20 \mathrm{k} \Omega$. Note that this configuration will increase the current consumption by several hundreds of microamps. Accuracy is excellent down to 0 V and as low as -2 mV . Limiting and nonlinearity occurs below -2 mV , but excellent accuracy returns as the output is again driven above -2 mV . Lowering the resistance of the pulldown resistor allows the op amp to swing even further below the negative rail. Resistances as low as $10 \mathrm{k} \Omega$ can be used to achieve excellent accuracy down to -10 mV .

## General Layout Guidelines

Attention to good layout practices is always recommended. Keep traces short and, when possible, use a printed circuit board (PCB) ground plane with surface-mount components placed as close to the device pins as possible. Place a $0.1-\mu \mathrm{F}$ capacitor closely across the supply pins. These guidelines should be applied throughout the analog circuit to improve performance and provide benefits, such as reducing the electromagnetic interference (EMI) susceptibility.
Operational amplifiers vary in their susceptibility to radio frequency interference (RFI). RFI can generally be identified as a variation in offset voltage or dc signal levels with changes in the interfering RF signal. The OPA333A has been specifically designed to minimize susceptibility to RFI and demonstrates remarkably low sensitivity compared to previous-generation devices. Strong RF fields may still cause varying offset levels.


Figure 3. Temperature Measurement
Figure 4 shows the basic configuration for a bridge amplifier.


Figure 4. Single Op-Amp Bridge Amplifier
A low-side current shunt monitor is shown in Figure 5. $R_{N}$ are operational resistors used to isolate the ADS1100 from the noise of the digital $I^{2} \mathrm{C}$ bus. Since the ADS1100 is a 16 -bit converter, a precise reference is essential for maximum accuracy. If absolute accuracy is not required, and the $5-\mathrm{V}$ power supply is sufficiently stable, the REF3130 may be omitted.


NOTE: $1 \%$ resistors provide adequate common-mode rejection at small ground-loop errors.

Figure 5. Low-Side Current Monitor

2) Current-limiting resistor.
(3) Choose zener biasing resistor or dual NMOSFETS (FDG6301N, NTJD4001N, or Si1034)

Figure 6. High-Side Current Monitor


Figure 7. Thermistor Measurement


Figure 8. Precision Instrumentation Amplifier


Figure 9. Single-Supply, Very-Low-Power ECG Circuit

Texas

## PACKAGING INFORMATION

| Orderable Device | Status <br> (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan <br> (2) | Lead finish/ Ball material <br> (6) | MSL Peak Temp <br> (3) | Op Temp ( ${ }^{\circ} \mathrm{C}$ ) | Device Marking <br> (4/5) | Samples |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| OPA2333AMDREP | ACTIVE | SOIC | D | 8 | 2500 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -55 to 125 | $2333 E P$ | Samples |
| OPA333AMDBVREP | ACTIVE | SOT-23 | DBV | 5 | 3000 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | 0 to 0 | OBYM | Samples |
| OPA333AMDCKREP | ACTIVE | SC70 | DCK | 5 | 3000 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | 0 to 0 | CHQ | Samples |
| V62/07633-01XE | ACTIVE | SOT-23 | DBV | 5 | 3000 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -55 to 125 | OBYM | Samples |
| V62/07633-01YE | ACTIVE | SC70 | DCK | 5 | 3000 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | 0 to 0 | CHQ | Samples |
| V62/07633-02ZE | ACTIVE | SOIC | D | 8 | 2500 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -55 to 125 | 2333EP | Samples |

${ }^{(1)}$ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device
${ }^{(2)}$ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed $0.1 \%$ by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free"
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine ( Cl ) and Bromine ( Br ) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement
${ }^{(3)}$ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
${ }^{(4)}$ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
${ }^{(5)}$ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
${ }^{(6)}$ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION


TAPE DIMENSIONS


| A0 | Dimension designed to accommodate the component width |
| :---: | :--- |
| B0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

Reel Width (W1)
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

*All dimensions are nominal

| Device | Package <br> Type | Package <br> Drawing | Pins | SPQ | Reel <br> Diameter <br> $(\mathbf{m m})$ | Reel <br> Width <br> W1 $(\mathbf{m m})$ | A0 <br> $(\mathbf{m m})$ | B0 <br> $(\mathbf{m m})$ | K0 <br> $(\mathbf{m m})$ | P1 <br> $(\mathbf{m m})$ | W <br> $(\mathbf{m m})$ | Pin1 <br> Quadrant |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| OPA2333AMDREP | SOIC | D | 8 | 2500 | 330.0 | 12.4 | 6.4 | 5.2 | 2.1 | 8.0 | 12.0 | Q1 |
| OPA333AMDBVREP | SOT-23 | DBV | 5 | 3000 | 179.0 | 8.4 | 3.2 | 3.2 | 1.4 | 4.0 | 8.0 | Q3 |
| OPA333AMDCKREP | SC70 | DCK | 5 | 3000 | 179.0 | 8.4 | 2.2 | 2.5 | 1.2 | 4.0 | 8.0 | Q3 |


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| OPA2333AMDREP | SOIC | D | 8 | 2500 | 356.0 | 356.0 | 35.0 |
| OPA333AMDBVREP | SOT-23 | DBV | 5 | 3000 | 200.0 | 183.0 | 25.0 |
| OPA333AMDCKREP | SC70 | DCK | 5 | 3000 | 203.0 | 203.0 | 35.0 |



ALTERNATIVE PACKAGE SINGULATION VIEW

## NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Refernce JEDEC MO-178.
4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.
5. Support pin may differ or may not be present.


SOLDER MASK DETAILS

NOTES: (continued)
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.


SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:15X

NOTES: (continued)
8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.


NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed . 006 [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.


SOLDER MASK DETAILS

NOTES: (continued)
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.


NOTES: (continued)
8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.



ALTERNATIVE PACKAGE SINGULATION VIEW

## NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Refernce JEDEC MO-203.
4. Support pin may differ or may not be present.
5. Lead width does not comply with JEDEC.
6. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side


NOTES: (continued)
7. Publication IPC-7351 may have alternate designs.
8. Solder mask tolerances between and around signal pads can vary based on board fabrication site.


SOLDER PASTE EXAMPLE BASED ON 0.125 THICK STENCIL SCALE:18X

NOTES: (continued)
9. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
10. Board assembly site may have different recommendations for stencil design.

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